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Luminescent response study of ionic crystals used in dosimetry

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Autor: Marta de la Rosa Núñez



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Índice general

Índice general	2
Índice de figuras	3
Índice de tablas	4
Resumen. Palabras clave	5
Abstract. Keywords	6
1. Introduction	7
2. Objectives	8
3.1. The mathematical model	9 9 12 13
4. Simulations	14
Conclusiones	15
Conclusions	16
Bibliografía	17
Anexo: Ejemplo para introducir código Matlab	18
Anexo: Ejemplo para introducir código ISE	19

Índice de figuras

3.1.	Fermi-Dirac distribution for a semicoductor that is irradiated	10
3.2.	Schematic representation of the theoretical model	10

Índice de tablas

Resumen

Escriba aquí un resumen de la memoria en castellano que contenga entre 100 y 300 palabras. Las palabras clave serán entre 3 y 6.

Palabras clave: palabra clave 1; palabra clave 2; palabra clave 3; palabra clave 4

Abstract

Insert here the abstract of the report with an extension between 100 and 300 words.

Keywords: keyword1; keyword2; keyword3; keyword4

CAPÍTULO 1

Introduction

As a bystander, one may pass life without thinking of the things that surrounds us. One may have had the misfortune of entering on an MRI, or the responsability to carry a dosimeter in a nuclear plant, and stepped out the room as it is. Life can go on unquestioned, and one may get out of that PET scan without thinking of the source of that awful noise.

There's beauty in the mundane, and the world is full of wonders. The universe is a complex system of interactions, and we know a very small part of it. We are surrounded by radiation, and we are constantly exposed to it. It is a natural phenomenon that has been present since the beginning of time, and it is an integral part of our existence. There are answers for those who wonder, and this work is a very small step towards it.

Luminescence is a phenomenon familiar to us; and goes through our lives like a commercial break. We see it in the glow of a firefly, the sparkle of a diamond, or the light emitted by a fluorescent lamp. In a nutshell, it is a process where energy is absorbed and re-emitted as light, leaving a trail behind, and can be triggered by various stimuli, like heat, light or radiation. This broad notion is the reason why the study of luminescence has practical uses in many fields. One of those fields of use is the detection of ionizing radiation, a field generally known as "dosimetry". The amount of radiation absorbed by a material can be measured by the amount of light emitted when the material is stimulated, and this is the basis for many dosimetry techniques. These luminescence-based methods for detecting ionizing radiation have played a central role in radiation research since the earliest discoveries of radiation, as they exploit the ability of specific materials to emit light when exposed to ionizing radiation, to detect and quantify the radiation received, further expanding the knowledge its efect.

One of the most commonly used materials in this context is lithium fluoride doped with magnesium and titanium (LiF:Mg,Ti). This material exhibits thermoluminescence, a phenomenon where trapped electrons in the crystal lattice are released upon heating, emitting light in the process. The study of such materials is crucial for improving the accuracy and efficiency of radiation detection systems, and it will be the cornerstone of this work.

CAPÍTULO 2

Objectives

Theoretical framework

3.1. THE MATHEMATICAL MODEL

To describe the thermoluminescent response of a semicoductor, we can use a mathematical model based on the trapping and releasing of charge carriers in the accesible energy levels of the material.

Let us first consider the case of an arbitrary semicoductor without impurities. The energy levels of the conduction band and the valence band are separated by a bandgap E_g , and can be obtained with Schrodinger's equation that is under the influence of a periodic potential:

$$\left[-\frac{\hbar^2}{2m} \nabla^2 + V(\vec{r}) \right] \psi(\vec{r}) = E \ \psi(\vec{r}), \tag{3.1}$$

The periodicity of the potential $V(\vec{r})$ for any lattice vector \vec{R} allows the Bloch's theorem to apply, and so it gives rise to the formation of a band structure, composed by the conduction band, which is typically fully occupied at absolute zero temperature, and the valence band, which is in turn typically empty -or rather, we can consider it filled with holes (h^+) , or "positively charged electrons". The bandgap E_g is then defined as the energy difference between the top of the valence band and the bottom of the conduction band, and for a perfect crystal, no energy states are allowed in that region. This can be clearly seen if we take into account the density of available states, D(E), which is a function of the Fermi-Dirac distribution f(E) for a certain temperature T. This function gives the occupancy of any energy level E, and can be expressed as:

$$f(E) = \frac{1}{e^{\frac{E - E_f}{k_B T}} + 1},$$
(3.2)

Where E_f is the Fermi Level, and k_B is the Boltzmann constant. If the system is in equilibrium, and we set the case of T = 0K, the occupancy function f(E) will be equal

to 1 for all energy levels below the Fermi level, and 0 for all energy levels above it. This means that the occupancy function will be a step function, with a discontinuity at the Fermi level, and so we can see that there are no available states in the bandgap region.

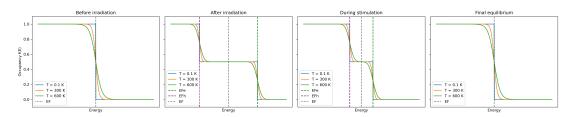


Figura 3.1: Fermi-Dirac distribution for a semicoductor that is irradiated.

The introduction of impurities or defects however, break the periodicity of the lattice, and create localized energy levels inside this "forbidden region". These levels can be thought of as traps for electrons if we are situated above the fermi level, and traps of holes if we are situated below. When this material is irradiated, electrons from the valence band can be excited to the conduction band, creating an electron-hole pair; and so changing the shape of the occupancy function. Once excited, both electrons and holes get "trapped" in these localized energy levels, and the excitation of these pairs into equilibrium will result in the emission of energy. In Figure 3.1 we can see a broad description of the perturbation of the system from its equilibrium state due to the irradiation, and the return of the system to equilibrium during either thermal stimulation or optical stimulation. If said relaxation processes are radiative, TL and OSL result.

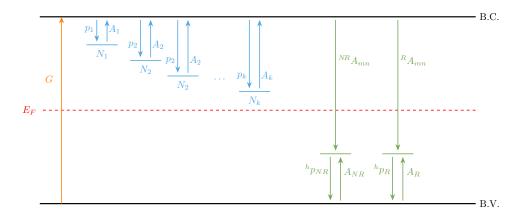


Figura 3.2: Schematic representation of the theoretical model.

And so, we can see a schematic representation of our theoretical model in Figure 3.2. Situating the energy in the Y axis, the focus is set in the energy gap of our material. Drawn as a blue or green horizontal line are the energy traps; in blue above the Fermi level there are electron traps, and in green there are hole traps or recombination centers. The vertical arrows describe available transitions; the ones pointing upwards represent an excitation process, and the ones pointing downwards represent a relaxation process.

Mathematically, we can describe these processes with a set of differential equations that take into account the rate of change of the number of electrons and holes in the bands and traps. This set will depend on the properties of the material, and the luminescence response we are trying to model. For an arbitrary system, we can write the following set

of equations that describe the rate of change of the number of electrons and holes in the conduction band n_c , the valence band n_v :

$$\frac{dn_c}{dt} = G - \left[\sum_i \frac{dn_i}{dt}\right] \cdot n_c - \left[\sum_{j=R,NR} {}^i A_{mn} \cdot m_j\right] \cdot n_c \tag{3.3}$$

$$\frac{dn_i}{dt} = -p_i \cdot n_i + A_i \cdot [N_i - n_i] \tag{3.4}$$

$$\frac{dm_j}{dt} = -{}^{h}p_j \cdot m_j + A_j \cdot [M_j - m_j] \cdot n_v - {}^{i}A_{mn} \cdot m_j \cdot n_c$$
(3.5)

$$\frac{dn_v}{dt} = G - \sum_{j=R,NR} \left[-{}^h p_j \cdot m_j + A_j \cdot [M_j - m_j] \cdot n_v \right]$$
(3.6)

Where every term is defined as follows:

- G: electron-hole pairs generated by the radiation [cm⁻³ s⁻¹]
- n_c : electron density in the conduction band [cm⁻³]
- n_v : electron density in the valence band [cm⁻³]
- n_i : electron density in trap i [cm⁻³]
- m_i : hole density in the recombination center j [cm⁻³]
- N_i : total density of ???
- M_i : total density of ???
- p_i : electron release probability factor for trap i [s⁻¹]
- ${}^{h}p_{j}$: hole release probability factor for recombination center j [s⁻¹]
- A_i : electron trapping probability factor for trap i [cm³ s⁻¹]
- ${}^{i}A_{mn}$: recombination probability factor for recombination center j [cm³ s⁻¹]

Equation 3.3 describes the change rate of electron concentrations in the conduction band. To interpret this equation, we can see that to the electron-hole pairs generated by the radiation (G), there are two terms substracted. The first one correlates to the electrons that leave the continuum levels of the conduction band and get trapped in the discrete levels of the material —a process described by 3.4, that will have a further discussion in section 3.2—, and the second one answers to the electrons in the conduction band that recombine with holes with a radiative (R) or non-radiative (NR) process. It is easy to see that this second term corresponds to the third term of 3.5.

The change rate of electron concentrations in the valence band is shown in 3.6, and it follows a similar logic. This time however, we only take into account the terms multiplied by the electron density in the valence band (n_v) seen in equation 3.5; one that represents the holes leaving the continuum to get trapped in the recombination centers, and another that accounts for the addition of electrons that are released from the recombination centers and recombine with the holes in the valence band. The terms described correspond to Equations 3.4 and 3.5 describe the total change rate of electrons and holes in the discrete levels of the material. The signs of the terms in these equations follow the convention that

we are set in the conduction band, and so any electron that leaves the conduction band is represented with a negative term, and any electron that enters is represented with a positive term.

Luminescence results when the electrons and holes recombine, so its intensity will be proportional to the number of recombinations that occur, given by equation 3.5 [2]. Assuming that after irradiation there is no further hole trapping, the luminescence intensity (I) can be expressed as:

$$I(t) \approx {}^{R}A_{mn} \cdot m_{R} \cdot n_{c} \tag{3.7}$$

Representing this intensity as a function of time will be the objective of the simulations, as it is the key to understand the thermoluminescent response of the LiF: Mg, Ti after being irradiated.

3.2. The frequency factor

As introduced in Section 3.1, there is a greater discussion to be had about the releasing probability of electrons and holes, as it determines in great part the electron-hole pairs available to recombine. If we consider that after being irradiated, the material will release its carriers through thermal excitation, an electron trapped in a lattice defect with energy E_t and temperature T will have a probability of being released that follows Arrhenius equation. The probability per second that the electron will be thermally excited into the conduction band is given by:

$$p = s \cdot e^{-\frac{E_t}{k_B T}} \tag{3.8}$$

Where s is known as the *frequency factor*. It can be interpreted as the "attempt to escape" frequency, as it is a measure of the number of times per second that energy is absorbed from phonons in the lattice. The exponential that follows is the probability that the energy absorbed is enough to cause a transition from the localized state to the conduction band.

The frequency factor is a very important parameter in the study of thermoluminescence, as it determines the rate at which electrons are released from traps. It is a function of the material properties, as shown in its definition:

$$s = \nu \cdot K \cdot e^{\frac{\Delta S}{k_B}} \tag{3.9}$$

Where ν is the lattice phonon vibration frequency and K is the transition probability constant. Typically, one can expect $s \sim 10^{12}-10^{14}~{\rm s}^{-1}$, which is consistent with the values of ν for most solids. The term $e^{\frac{\Delta S}{k_B}}$ is a correction factor that accounts for the entropy change associated with the transition from the localized state to the conduction band.

3.3. ABOUT LIF:MG,TI

Lithium fluoride (LiF) is a crystalline material that has been widely used in radiation dosimetry due to its favorable properties. It first appeared as a thermoluminescent dosimetry material in the 1950's, and since then, it has been extensively studied in the field of radiation detection. The material is composed of lithium (Li) and fluor (F) atoms, forming a crystal lattice structure of a face-centered cubic (FCC) type. Without any impurities, LiF is a semiconductor, with a bandgap of approximately 14 eV, which makes it an excellent insulator at room temperature.

To enhance the properties for radiation detection, LiF is often doped with magnesium (Mg) and titanium (Ti) ions, and sold commercially as TLD-100 [1]. The doping process introduces defects in the crystal lattice, creating energy levels within the bandgap. These defects play a crucial role in trapping and releasing charge carriers, which are responsible for the thermoluminescent response of the material. This process is known as thermoluminescence (TL), where the trapped electrons are released upon heating, resulting in the emission of light. The intensity of this emitted light is proportional to the amount of radiation absorbed by the material, making it a valuable tool for dosimetry.

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Simulations

Conclusiones

En este trabajo \dots

Conclusions

In this work ...

Bibliografía

- [1] Y. S. Horowitz, L. Oster, and H. Datz, The thermoluminescence dose response and other characteristics of the high-temperature TL in LiF:Mg,Ti (TLD-100), *Radiation Protection Dosimetry*, vol. 124, no. 2, pp. 191–205, Jun. 2007, doi: 10.1093/rp-d/ncm241.
- [2] McKeever, Stephen W. S. (2022). A course in luminescence measurements and analyses for radiation dosimetry. Wiley. ISBN 978-1-119-64689-1.

Anexo: Ejemplo para introducir código Matlab

```
%% 3-D Plots
  % Three-dimensional plots typically display a surface
  % defined by a function in two variables, z = f(x,y).
  %%
4
  % To evaluate z, first create a set of (x,y) points
  % over the domain of the function using meshgrid.
      [X,Y] = meshgrid(-2:.2:2);
      Z = X .* exp(-X.^2 - Y.^2);
  %%
9
  \% Then, create a surface plot.
10
      surf(X,Y,Z)
11
12
  % Both the surf function and its companion mesh display
  % surfaces in three dimensions. surf displays both the
  % connecting lines and the faces of the surface in color.
  % Mesh produces wireframe surfaces that color only the
16
  %lines connecting the defining points.
```

Anexo: Ejemplo para introducir código ISE

```
library IEEE;
                 use IEEE.STD_LOGIC_1164.ALL;
                use IEEE.STD_LOGIC_ARITH.ALL;
3
                use IEEE.STD_LOGIC_UNSIGNED.ALL;
4
   - Uncomment the following library declaration if
5
   -- instantiating any Xilinx primitive in this code.
   - library UNISIM;
   -- use UNISIM.VComponents.all;
9
  entity counter is
       Port ( CLOCK : in
                           STD_LOGIC;
       DIRECTION :
                      in
                           STD_LOGIC;
12
       COUNT_OUT :
                     out STD_LOGIC_VECTOR (3 downto 0));
13
  end counter;
14
  architecture Behavioral of counter is
16
   signal count_int : std_logic_vector(3 downto 0) := "0000";
17
  begin
  process (CLOCK)
  begin
20
       if CLOCK='1' and CLOCK'event then
21
           if DIRECTION='1' then
22
               count_int <= count_int + 1;</pre>
23
24
           else
               count_int <= count_int - 1;</pre>
25
           end if;
26
       end if;
27
  end process;
28
  COUNT_OUT <= count_int;
29
  end Behavioral;
```